

85V N-Channel MOSFET

General Features

- Proprietary New Trench Technology
- ightharpoonup R_{DS(ON),typ.}=6.9 m Ω @V_{GS}=10V
- Low Gate Charge Minimize Switching Loss
- Fast Recovery Body Diode

Applications

- ➢ High efficiency DC/DC Converters
- Synchronous Rectification
- > UPS Inverter

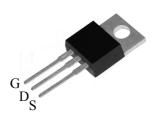
Ordering Information

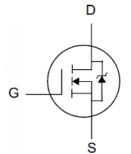
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Part Number	Package	Brand							
PTP08N08NA	TO-220	Z							

Pb

Lead Free Package

BV _{DSS}	R _{DS(ON),typ.}	I _D ^[2]
85V	6.9mΩ	105A





TO-220

Package No to Scale

Absolute Maximum Ratings

T_C=25 [°]C unless otherwise specified

Symbol	Parameter	PTP08N08NA	Unit	
V _{DSS}	Drain-to-Source Voltage ^[1]	85	V	
V _{GSS}	Gate-to-Source Voltage	±20	¬	
I _D	Continuous Drain Current ^[2]	105		
I _{D @ Tc =100} ℃	Continuous Drain Current @ Tc=100℃ ^[2]	77	A	
I _{DM}	Pulsed Drain Current at V _{GS} =10V ^[2,4]	420		
E _{AS}	Single Pulse Avalanche Energy	800	mJ	
dv/dt	Peak Diode Recovery dv/dt ^[3]	5.0	V/ns	
П	Power Dissipation	189	W	
P_D	Derating Factor above 25℃	1.3	W/°C	
T _L T _{PAK}	Maximum Temperature for Soldering Leads at 0.063in (1.6mm) from Case for 10 seconds, Package Body for 10 seconds	300 260	${\mathbb C}$	
T _J & T _{STG}	Operating and Storage Temperature Range	-55 to 175		

Caution: Stresses greater than those listed in the "Absolute Maximum Ratings" may cause permanent damage to the device.

Thermal Characteristics

Symbol	Parameter	PTP08N08NA	Unit
$R_{ heta JC}$	Thermal Resistance, Junction-to-Case	0.79	20
R _{θJA}	Thermal Resistance, Junction-to-Ambient	62	°C/ W



Electrical Characteristics

OFF Characteristics $T_J = 25^{\circ}\mathbb{C}$ unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
BV _{DSS}	Drain-to-Source Breakdown Voltage	85	-		٧	V _{GS} =0V, I _D =250uA
	Drain to Course Leglage Current			1		V _{DS} =80V, V _{GS} =0V
I _{DSS}	Drain-to-Source Leakage Current			100	uA	V_{DS} =64V, V_{GS} =0V, T_J =125°C
	I _{GSS} Gate-to-Source Leakage Current			+100	nA	V _{GS} =+20V, V _{DS} =0V
IGSS				-100	I IIA	V _{GS} =-20V, V _{DS} =0V

ON Characteristics

T_J =25 °C unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
R _{DS(ON)}	Static Drain-to-Source On-Resistance		6.9	8.0	mΩ	V_{GS} =10V, I_D =24A ^[5]
$V_{GS(TH)}$	Gate Threshold Voltage	2.0		4.0	٧	V_{DS} = V_{GS} , I_{D} =250uA

Dynamic Characteristics

Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
C _{iss}	Input Capacitance		3.4			V_{GS} =0V, V_{DS} =25V, f=1.0MH _Z
C _{rss}	Reverse Transfer Capacitance		0.13		nF	
C _{oss}	Output Capacitance		0.41			
Rg	Gate Series Resistance		1.8		Ω	f=1.0MH _Z
Qg	Total Gate Charge		62			
Q _{gs}	Gate-to-Source Charge		21		nC	V_{DD} =40V, I_{D} =80A, V_{GS} =0 to 10V
Q_{gd}	Gate-to-Drain (Miller) Charge		19			

Resistive Switching Characteristics

Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
td(ON)	Turn-on Delay Time		19		nS	V_{DD} =40V, I_{D} =80A, V_{GS} = 10V R_{G} =2.5 Ω
trise	Rise Time		25			
td(OFF)	Turn-Off Delay Time		97			
tfall	Fall Time		30			



Source-Drain Body Diode Characteristics

 T_J =25 $^{\circ}$ C unless otherwise specified

Symbol	Parameter	Min	Тур.	Max.	Unit	Test Conditions
I _{SD}	Continuous Source Current ^[2]			105	۸	Integral PN-diode in
I _{SM}	Pulsed Source Current ^[2]			420	Α	MOSFET
V _{SD}	Diode Forward Voltage		-	1.2	V	I _S =80A, V _{GS} =0V
trr	Reverse recovery time		42		ns	V_{GS} =0 V , IF=20 A ,
Qrr	Reverse recovery charge		84		nC	dir/dt=100A/µs

Note:

^[1] T_J=+25℃ to +175℃

^[2] Silicon limited current only.
[3] Package limited current 80A

^[4] Repetitive rating; pulse width limited by maximum junction temperature. [5] Pulse width≤380µs; duty cycle≤2%.



Typical Characteristics

Figure 1. Maximum Effective Thermal Impedance, Junction-to-Case

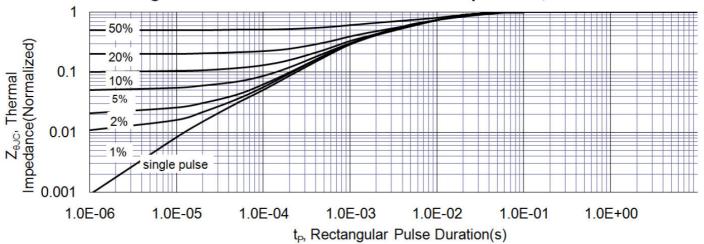


Figure 2. Maximum Power Dissipation vs. Case **Temperature** 200 180 160 P_D, Power Dissipation (W) 140 120 100 80 60 40 20 0 25 50 75 100 125 150 $T_{\mathbb{C}}$, Case Temperature ($^{\circ}\mathbb{C}$)

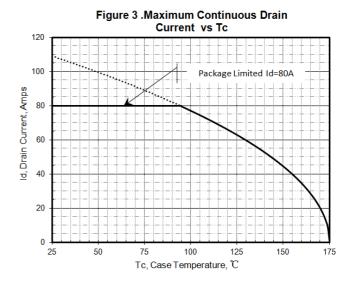
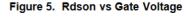
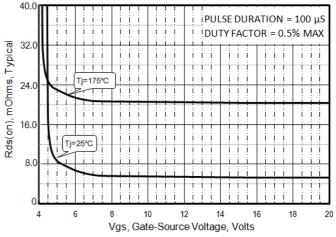


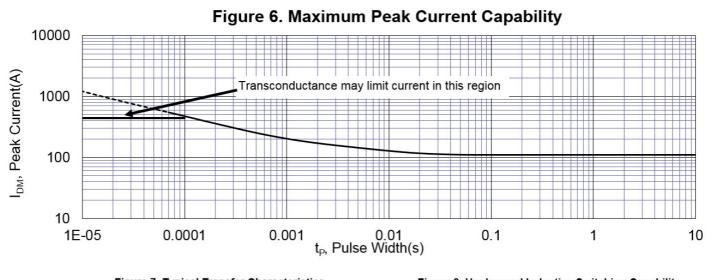
Figure 4. Typical Output Characteristics 300 250 _{GS}=5.0V Ip, Drain Current(A) 200 150 V_{GS}=4.5V 100 50 V_{GS}=4.0V 0 0 1.5 2 V_{DS}, Drain-to-Source Voltage(V)





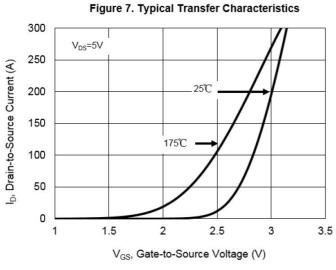


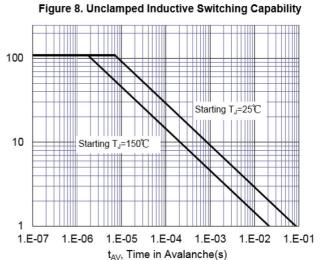
Typical Characteristics(Cont.)

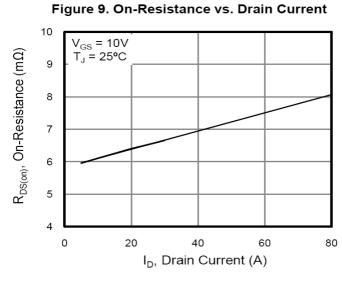


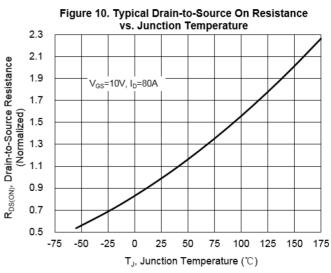
Avalanche Current(A)

AS,











Typical Characteristics(Cont.)

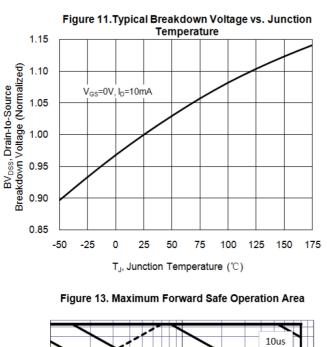
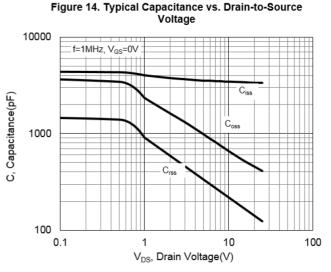


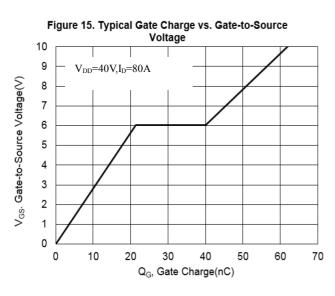
Figure 12. Typical Threshold Voltage vs. Junction **Temperature** 1.2 Threshold Voltage (Normalized) 1.1 1.0 0.9 0.8 0.7 0.6 $V_{GS}=V_{DS}$, $I_{D}=250uA$ V_{GS(ТН)} 0.5 0.4 -50 -25 0 25 50 75 100 125 150 175 T_J, Junction Temperature (°C)

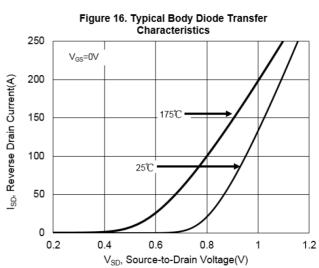
Operating in this area may be limited by R_{DS(ON)}

10

V_{DS}, Drain-to-Source Voltage(V)









Test Circuits and Waveforms

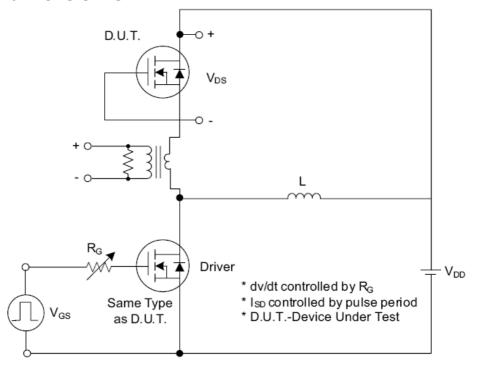


Fig. 1.1 Peak Diode Recovery dv/dt Test Circuit

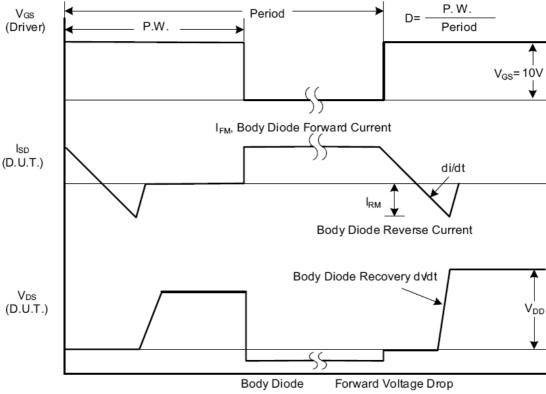


Fig. 1.2 Peak Diode Recovery dv/dt Waveforms



Test Circuits and Waveforms (Cont.)

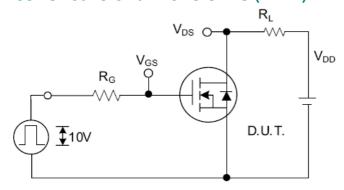


Fig. 2.1 Switching Test Circuit

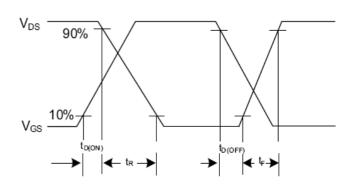


Fig. 2.2 Switching Waveforms

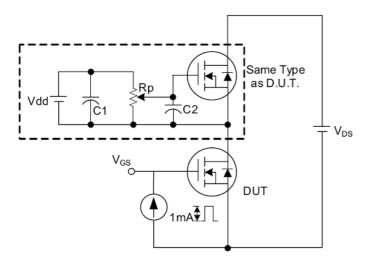


Fig. 3 . 1 Gate Charge Test Circuit

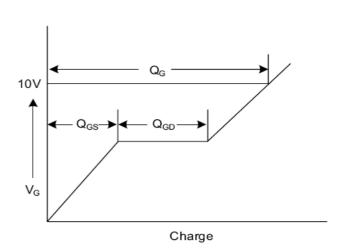


Fig. 3.2 Gate Charge Waveform

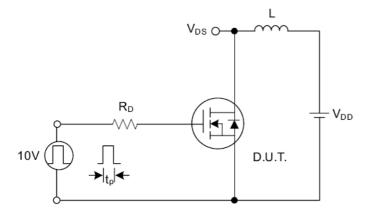


Fig. 4.1 Unclamped Inductive Switching Test Circuit

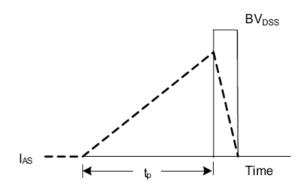


Fig. 4.2 Unclamped Inductive Switching Waveforms



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